

Nuclear Event Detector

First Generation NED (Technograph)

Product Brief



Micross continues to offer our First Generation (Technograph) NED for legacy or new equipment requiring cost-effective nuclear protection. The First Generation NED provides an output in response to gamma radiation, that is used to protect sensitive electronic circuitry.



KEY FEATURES

- Gamma Dose Rate Sensitivity Threshold Range Adjustable from 10⁶ to 10⁷ cGy/s at 25°C
- · Dual In-Line Package
- · Open Collector Outputs
- · Radiation Specifications
 - Total Dose (Device Survivability): 1 x 10⁴ cGy/s
 - Dose Rate (Operate Through): 2.5 x 109 cGy/s
 - Neutron Fluence (Operate Through): 1012 neutrons / cm2
- · 5V Power Requirement
- · -55°C to +125°C Extended Full MIL-Temperature Range
- BS9450 General Level or MIL-STD-883C Method 5008 Class B Screening Levels

BENEFITS

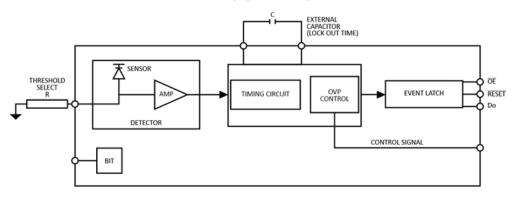
- · Cost Effective Solution for Nuclear Event Protection
- User Adjustable Delay or "Lock-Out" Time, Selected by Choice of Single External Capacitor
- Use Output Signal to Shut Down Power Supplies, Take Processors Off-Line and Block Memory Write Operations
- Incorporated Event Latch Offering Interfacing with the System Bus, Initiating Software Recovery, or Alerting the CPU

APPLICATIONS

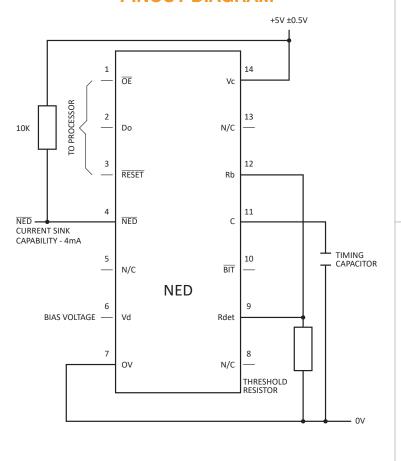
- · Aircrafts and Drones
- · Defense Weapon Systems
- · Satellites
- · Military Ground Vehicles
- · Nuclear Material Storage

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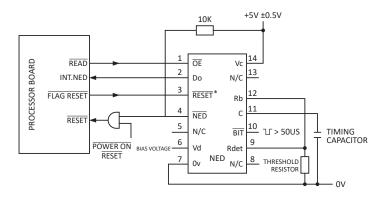
BLOCK DIAGRAM



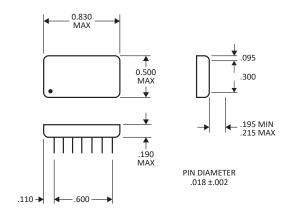
PINOUT DIAGRAM



PROCESS PROTECTION DURING EVENT



MECHANICAL OUTLINE



ORDERING INFORMATION MP13366/001



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